



## Notice of References Cited

Application/Control No.

10/019,560

Applicant(s)/Patent Under Reexamination VAN BAAL ET AL.

Examiner

Louis B Tran

Art Unit
Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,344,048	09-1994	Bonerb, Timothy C.	222/105
	В	US-6,032,818	03-2000	Olson, .ANG.ke	220/495.06
	C	US-4,955,512	09-1990	Sharples, Leonard	222/386.5
	D	US-3,377,766	04-1968	Nelson	53/449
	E	US-4,898,301	02-1990	Schick, Henning	229/117.27
	F	US-4,450,180	05-1984	Watkins, James D.	426/107
	G	US-3,143,249	08-1964	Merrill	222/105
	Н	US-5,698,056	12-1997	Kamiyama et al.	156/218
	ı	US-4,586,628	05-1986	Nittel, Walter F.	220/62.21
	J	US-4,786,192	11-1988	Graves et al.	383/119
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	1012.01								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification			
	N								
	0								
	Р								
	Q								
	R								
	s								
	Т								

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ					
	٧					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.